## **CLAIMS**

- A magnetic head including a read head structure, comprising: 1 1.
- a free magnetic layer, including a central region and outwardly disposed end regions 2
- thereof; 3
- at least two anti-parallel coupled magnetic layers being disposed above said end regions 4
- of said free magnetic layer. 5
- A magnetic head as described in claim 1 wherein a thin film nonmagnetic layer is 1 2. disposed between said at least two said magnetic layers.
  - A magnetic head as described in claim 1 wherein a magnetic seed layer is disposed on top 3. of said end regions of said free magnetic layer, and a first one of said at least two magnetic layers is disposed on top of said seed layer
  - A magnetic head as described in claim 3 wherein said seed layer is formed with a BCC 4.
  - 2 crystal structure.
  - A magnetic head as described in claim 4, wherein said seed layer is comprised of 1 5.
  - CoFeCr, and has a thickness of from approximately 10 Å to approximately 50 Å. 2

- 1 6. A magnetic head as described in claim 3 wherein a thin film nonmagnetic layer is
- 2 disposed on top of said first magnetic layer, and a second one of said at least two magnetic layers
- 3 is disposed on top of said nonmagnetic layer.
- 1 7. A magnetic head as described in claim 6 wherein said first and second magnetic layers
- 2 are comprised of CoPtCr, and said first magnetic layer has a thickness that is from approximately
- 3 20 Å to approximately 30 Å and said second magnetic layer has a thickness of from
- 4 approximately 30 Å to approximately 80 Å.

- 8. A magnetic head as described in claim 7 wherein said non-magnetic layer is comprised of Ru and has a thickness that is approximately 8 Å.
- 9. A magnetic head as described in claim 7 wherein said seed layer has a thickness, and the total thickness of said seed layer plus said first magnetic layer is greater than the thickness of said second magnetic layer.
- 1 10. A magnetic head as described in claim 1, wherein said anti-parallel coupled magnetic
- 2 layers have a net magnetostatic field in the same direction as a magnetic field of said free layer.
- 1 11. A magnetic head as described in claim 3, wherein a third thin film magnetic layer is
- 2 disposed between said first magnetic layer and said nonmagnetic layer, and a fourth magnetic
- 3 layer is disposed between said nonmagnetic layer and a second magnetic layer.

- 1 12. A magnetic head as described in claim 11, wherein said third magnetic layer and said
- 2 fourth magnetic layer are comprised of CoFe.
- 1 13. A magnetic head including a GMR sensor, comprising:
- a plurality of thin film layers forming a GMR sensor, wherein at least one of said layers
- 3 is a free magnetic layer, said free magnetic layer including a central portion and two outwardly
- 4 disposed end regions thereof;
- 5 a magnetic seed layer being disposed upon said end regions;
- a first magnetic layer being disposed upon said seed layer;
  - a nonmagnetic layer being disposed upon said first magnetic layer;
  - a second magnetic layer being disposed upon said nonmagnetic layer;
  - wherein said first magnetic layer is formed with a magnetic field and said second magnetic layer is formed with a magnetic field, and wherein the magnetic fields of said first magnetic layer and said magnetic layer are anti-parallel coupled.
  - 14. A magnetic head as described in claim 13, wherein said free magnetic layer is formed
- 2 with a magnetic field in a first direction and said anti-parallel coupled magnetic field of said first
- 3 magnetic layer and said second magnetic layer is formed with a magnetostatic bias in the same
- 4 direction as the magnetic field of said free magnetic layer.
- 1 15. A magnetic head as described in claim 13 wherein said seed layer is formed with a BCC
- 2 crystal structure.

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- 1 16. A magnetic head as described in claim 15 wherein said seed layer is comprised of
- 2 CoFeCr, and said first magnetic layer is comprised of CoPtCr, and said nonmagnetic layer is
- 3 comprised of Ru, and said second magnetic layer is comprised of CoPtCr.
- 1 17. A magnetic head as described in claim 16 wherein a layer being comprised of CoFe is
- 2 disposed between said first magnetic layer and said nonmagnetic layer, and a second layer
- 3 comprised of CoFe is disposed between said nonmagnetic layer and said second magnetic layer.
- 1 18. A hard disk drive including a magnetic head having a read head structure, comprising:
  - a free magnetic layer, including a central region and outwardly disposed end regions thereof; at least two anti-parallel coupled magnetic layers being disposed above said end regions of said free magnetic layer.
  - 19. A hard disk drive as described in claim 18 wherein a thin film nonmagnetic layer is disposed between said at least two magnetic layers.
- 1 20. A hard disk drive as described in claim 18 wherein a magnetic seed layer is disposed on
- 2 top of said end regions of said free magnetic layer, and a first one of said at least two magnetic
- 3 layers is disposed on top of said seed layer
- 1 21. A hard disk drive as described in claim 20 wherein said seed layer is formed with a BCC
- 2 crystal structure.

- 2 CoFeCr, and has a thickness of from approximately 10 Å to approximately 50 Å.
- 1 23. A hard disk drive as described in claim 20 wherein a thin film non-magnetic layer is
- 2 disposed on top of said first magnetic layer, and a second one of said at least two magnetic layers
- 3 is disposed on top of said non-magnetic layer.
- 1 24. A hard disk drive as described in claim 23 wherein said first and second magnetic layers
  - are comprised of CoPtCr, and wherein said first magnetic layer has a thickness that is from
    - approximately 20 Å to approximately 30 Å and said second magnetic layer has a thickness that is
    - from approximately 30 Å to approximately 80 Å.
    - 25. A hard disk drive as described in claim 24 wherein said non-magnetic layer is comprised
    - of Ru and has a thickness that is approximately 8 Å.
  - 26. A hard disk drive as described in claim 24 wherein said seed layer has a thickness, and
- 2 the total thickness of said seed layer plus said first magnetic layer is greater than the thickness of
- 3 said second magnetic layer.

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- 1 27. A hard disk drive as described in claim 18, wherein said anti-parallel coupled magnetic
- 2 layers have a net magnetostatic field in the same direction as a magnetic field of said free layer.

- 1 28. A hard disk drive as described in claim 20, wherein a third thin film magnetic layer is
- 2 disposed between said first magnetic layer and said non-magnetic layer, and a fourth magnetic
- 3 layer is disposed between said non-magnetic layer and a second magnetic layer.
- 1 29. A hard disk drive as described in claim 28, wherein said third magnetic layer and said
- 2 fourth magnetic layer are comprised of CoFe.
- 1 30. A method for fabricating a read head structure of a magnetic head, comprising the steps
- 2 of:
  - fabricating a plurality of thin film layers to create a GMR sensor, said layers including a
  - free magnetic layer having a central portion and outwardly disposed end portions;
  - fabricating at least two magnetic layers above said end portions of said free magnetic
  - layer, wherein said at least two magnetic layers have magnetic fields that are anti-parallel
  - coupled.
  - 31. A method for fabricating a read head structure as described in claim 30, including the
- 2 steps of:
- fabricating a seed layer on top of said end portions of said free magnetic layer;
- 4 fabricating a first said magnetic layer on top of said seed layer;
- fabricating a nonmagnetic layer above said first magnetic layer; and
- fabricating a second said magnetic layer above said nonmagnetic layer.

- 1 32. A method for fabricating a read head structure as described in claim 31, wherein a net
- 2 magnetostatic field is produced by said anti-parallel coupled magnetic layers, said net
- 3 magnetostatic field being formed in the same direction as a magnetic field of said free magnetic
- 4 layer.

- 1 33. A method for fabricating a read head structure as described in claim 31 wherein said seed
- 2 layer is comprised of CoFeCr, said first magnetic layer is comprised of CoPtCr, said
- 3 nonmagnetic layer is comprised of Ru and said second magnetic layer is comprised of CoPtCr.
  - 34. A method for fabricating a read head structure as described in claim 33 wherein said seed layer is fabricated with a BCC crystal structure.
  - 35. A method for fabricating a read head structure as described in claim 34 including the further steps of fabricating a layer comprised of CoFe between said first magnetic layer and said nonmagnetic layer, and fabricating a second layer comprised of CoFe between said nonmagnetic layer and said second magnetic layer.